

<b>Notice of References Cited</b>		Application/Control No. 10/566,722	Applicant(s)/Patent Under Reexamination WATANABE ET AL.	
		Examiner G. NAGESH RAO	Art Unit 1792	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-3,141,802 A	07-1964	WENTORF JR ROBERT H	252/62.3GA
*	B US-3,212,851 A	10-1965	WENTORF JR ROBERT HENRY et al.	423/290
*	C US-3,212,852 A	10-1965	BUNDY FRANCIS P	423/290
*	D US-3,233,988 A	02-1966	WENTORF JR ROBERT H et al.	51/307
*	E US-3,772,428 A	11-1973	Fleischer et al	423/290
*	F US-2006/0185577 A1	08-2006	Watanabe et al.	117/002
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP 2001072499 A	03-2001	Japan	SASAKI et al.	
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.